

<b>Notice of References Cited</b>	Application/Control No. 09/925,059		Applicant(s)/Patent Under Reexamination ZHANG, EVAN Y.W.	
	Examiner Shun Lee		Art Unit 2878	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-3,379,830 A	04-1968	Menke, Joseph F.	348/35
	B	US-4,488,414 A	12-1984	Jungkman et al.	62/51.1
	C	US-4,632,498 A	12-1986	Neil, Iain A.	359/354
	D	US-4,786,966 A	11-1988	Hanson et al.	348/158
	E	US-4,949,378 A	08-1990	Mammone, Richard J.	380/276
	F	US-5,336,899 A	08-1994	Nettleton et al.	250/559.29
	G	US-5,389,788 A	02-1995	Grinberg et al.	250/331
	H	US-5,497,266 A	03-1996	Owen, Larry D.	359/353
	I	US-5,683,831 A	11-1997	Baril et al.	429/96
	J	US-5,726,671 A	03-1998	Ansley et al.	320/119
	K	US-6,075,661 A	06-2000	Gross et al.	359/819
	L	US-6,335,526 B1	01-2002	Horn, Stuart B.	250/332
	M	US-6,379,009 B1	04-2002	Ferguson, James L.	353/28

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
	W	
	X	

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